# **NCX8200**

# Audio jack configuration switch matrix Rev. 1 — 15 May 2015

**Product data sheet** 

#### 1. **General description**

The NCX8200 is an advanced audio jack configuration switch matrix device that supports 3- and 4-pole connectors. It allows reconfiguration of the GND, microphone-bias contact to comply with the American Headset Jack (AHJ) and the Open Mobile Terminal Platform (OMTP) pinout. Furthermore, a GND sense path supports quasi-differential amplifier architectures. The device contains Human Body Model compliant ESD protection diodes rated 8 kV at all pins. The device can be operated from a supply in the range of 1.6 V to 3.6 V. It supports a broad variety of after-market headphones.

#### **Features and benefits** 2.

- AHJ and OMTP headset jack pinout support
- Low supply current
- Sense path to GND for quasi differential amplifier configuration
- Low THD and noise microphone pass through channel
- Ultra low R<sub>DSon</sub> of ground and sense switches
- High power supply ripple rejection
- ESD protection: HBM JEDEC JDS-001 Class 3B exceeds 8 kV
- Operating ambient temperature: -40 °C to +85 °C
- 1.22 mm × 1.22 mm × 0.5 mm WLCSP9 package

# **Applications**

Headphones with integrated microphone and remote control buttons

# **Ordering information**

#### Table 1. **Ordering information**

Type number	Package		
	Name	Description	Version
NCX8200UK	WLCSP9	wafer chip-scale package; 9 bumps; 1.22 × 1.22 × 0.5 mm	NCX8200UK

#### 5. Marking

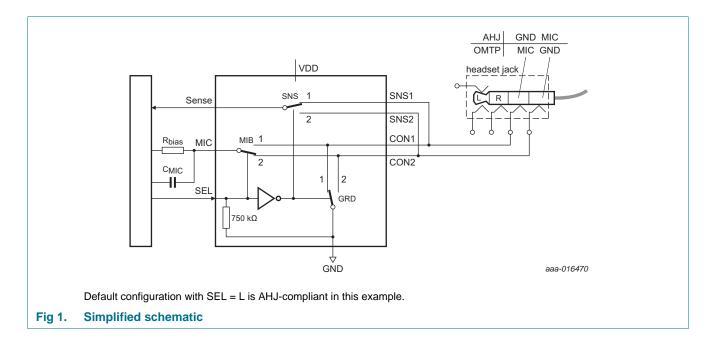
#### Table 2. **Marking codes**

Type number	Marking code
NCX8200UK	qx82



# Audio jack configuration switch matrix

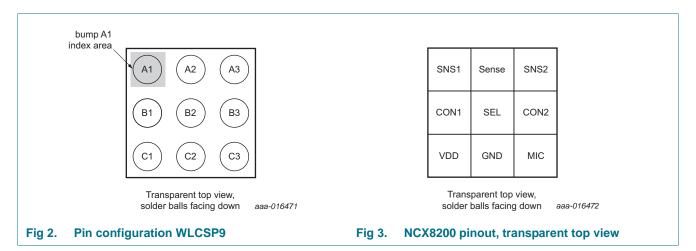
# 6. Functional diagram



Audio jack configuration switch matrix

# 7. Pinning information

#### 7.1 Pinning



### 7.2 Pin description

Table 3. Pin description

Symbol	Pin	Туре	Description	
SNS1	A1	I/O	analog sense path 1 to headset jack GND	
Sense	A2	I/O	analog sense path for GND sensing	
SNS2	А3	I/O	analog sense path 2 to headset jack GND	
CON1	B1	I/O	headset jack pin 1	
SEL	B2	I	configuration select input: SEL = L: CON1 = GND, CON2 = MIC, Sense = SNS1 SEL = H: CON1 = MIC, CON2 = GND, Sense = SNS2	
CON2	В3	I/O	headset jack pin 2	
VDD	C1	power	core supply	
GND	C2	ground	ground	
MIC	C3	I/O	microphone bias connection audio codec side	

# 8. Functional description

The basic application of the NCX8200 device is shown in Figure 1.

There is a 750 kW pull down resistor at SEL pin, for setting SEL default LOW.

If SEL is at low level, CON1 is connected to GND, the MIC channel is routed to CON2, and the Sense channel switches to SNS1. If SEL is at high level, CON2 is connected to GND, the MIC channel is routed to CON1, and the Sense channel switches to SNS2.

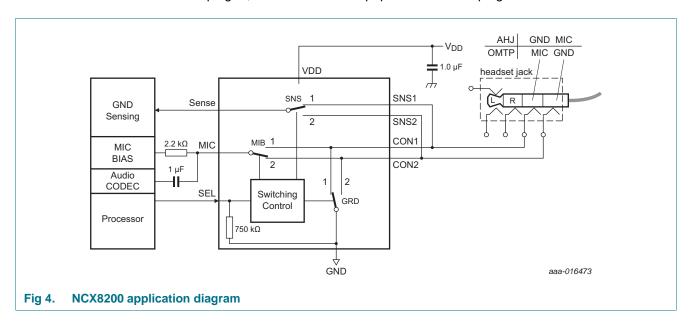
#### Audio jack configuration switch matrix

# 9. Application diagram

A capacitor of value not less than 1  $\mu$ F, should be placed between VDD and GND for stable operation of the NCX8200. The bypass capacitor should be placed close to the device with low-ohmic connection from the power supply and GND connection.

SNS1 should be for sensing CON1 connection and SNS2 should be for sensing CON2 connection. In PCB design, CONx routes from the headset jack should be as low-ohmic as possible. SNSx sensing nodes should be as close to the headset jack as possible with low-ohmic connection, so that the star connection is recommended. The routes from sensing nodes to SNSx should be as low-ohmic as possible.

When VDD is not powered, all the FETs become open by default. Thus, the ground return path becomes floating. Noise might be heard if a speaker (with external powered amplified) is plugged in the audio jack. It is highly recommended when the audio jack detects a plug-in, the NCX8200 is kept powered until unplug.



#### Audio jack configuration switch matrix

# 10. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DD}$	supply voltage		-0.5	+3.6	V
V <sub>I/O</sub>	input/output voltage	MIC, CON1, CON2, Sense, SNS1, SNS2	-0.5	$V_{DD}$	V
V <sub>I</sub>	input voltage	SEL	-0.5	V <sub>DD</sub> + 0.1	V
I <sub>SW(GRD)</sub>	switch current	continuous current from CON1 or CON2 to GND	-	100	mA
I <sub>SW(MIB)</sub>	switch current	continuous current from MIC to CON1 or CON2	-	50	mA
I <sub>SW(SNS)</sub>	switch current	continuous current from Sense to SNS1 or SNS2	-	50	mA
T <sub>j(max)</sub>	maximum junction temperature		-40	+125	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C
P <sub>tot</sub>	total power dissipation		-	530	mW

# 11. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DD}$	supply voltage		1.6	3.6	V
V <sub>I/O</sub>	input/output voltage	MIC, CON1, CON2, Sense, SNS1, SNS2	-0.3	$V_{DD}$	V
VI	input voltage	SEL	-0.3	$V_{DD}$	V
T <sub>amb</sub>	ambient temperature		-40	+85	°C

### 12. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	[1][2]	75.5	K/W

<sup>[1]</sup> The overall  $R_{th(j-a)}$  can vary depending on the board layout. To minimize the effective  $R_{th(j-a)}$ , all pins must have a solid connection to larger Cu layer areas e.g. to the power and ground layer. In multi-layer PCB applications, the second layer should be used to create a large heat spreader area right below the device. If this layer is either ground or power, it should be connected with several vias to the top layer connecting to the device ground or supply. Try not to use any solder-stop varnish under the chip.

<sup>[2]</sup> Rely on the measurement data given for rough estimation of the  $R_{th(j-a)}$  in your application. The actual  $R_{th(j-a)}$  value may vary in applications using different layer stacks and layouts.

### Audio jack configuration switch matrix

# 13. Static characteristics

#### Table 7. Static characteristics

At recommended operating conditions  $T_{amb} = -40 \, ^{\circ}\text{C}$  to +85  $^{\circ}\text{C}$  unless otherwise specified. Typical values are measured with  $V_{DD} = 3.0 \, \text{V}$  and  $T_{amb} = 25 \, ^{\circ}\text{C}$ . Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
Digital contr	rol						
V <sub>IH</sub>	HIGH-level input voltage	SEL input	1.0	-	-	V	
V <sub>IL</sub>	LOW-level input voltage	SEL input	-	-	0.4	V	
R <sub>pd</sub>	pull-down Resistor	SEL input	-	750	-	kΩ	
Current con	sumption		,				
I <sub>DD</sub>	Quiescent current	$V_{DD} = 3.0 \text{ V; } T_{amb} = 25 ^{\circ}C$	-	0.1	1	μΑ	
		V <sub>DD</sub> = 3.0 V; T <sub>amb</sub> = 85 °C	-	-	5	μΑ	
Microphone	bias switch MIB		,		,	·	
I <sub>S(MIB)</sub>	MIB Path leakage current	MIC; $V_{MIC}$ = 850 mV; CONx open; SEL = H or L	-	-	1.5	μΑ	
R <sub>ON(MIB)</sub>	MIB switch-on resistance	I <sub>O</sub> = 30 mA, V <sub>I</sub> = 850 mV					
		V <sub>DD</sub> = 1.8 V	-	1.6	2.5	Ω	
		V <sub>DD</sub> = 3.0 V	-	0.5	0.8	Ω	
		V <sub>DD</sub> = 3.6 V	-	0.46	0.7	Ω	
R <sub>ON(MIB_flat)</sub>	MIB switch-on resistance flatness	I <sub>O</sub> = 30 mA, 0.8 V < V <sub>I</sub> < 1.2 V			,		
		V <sub>DD</sub> = 1.8 V	-	-	5	Ω	
		V <sub>DD</sub> = 3.0 V	-	-	0.1	Ω	
		V <sub>DD</sub> = 3.6 V	-	-	0.1	Ω	
Cs	input/output capacitance	MIC; CONx open; SEL = H or L	-	250	-	pF	
THD	total harmonic distortion of the conducting MIB switch	$R_S = R_L = 600 \Omega$ , $f_{AC} = 20 \text{ kHz}$ , $V_{AC} = 0.5 V_{PP}$ , $V_{DC} = 1.7 V$ , $V_{DD} = 3.0 V$ ; $SEL = H \text{ or } L$	-	0.005	-	%	
PSRR	power supply ripple rejection ratio of the conducting MIB switch	$R_S = R_L = 600 \Omega$ , $f = 217 Hz$ , $V_{DD} = 3.0 V$ , $V_{DC} = 2.1 V$ , $V_{AC} = 0.3 V_{PP}$ ; $SEL = H \text{ or } L$	-	-80	-	dB	
Ground swit	tch GRD				<u> </u>		
R <sub>ON(GRD)</sub>	GRD	I <sub>ICONx</sub> = 100 mA					
	switch on resistance	V <sub>DD</sub> = 1.8 V	-	70	120	$m\Omega$	
		V <sub>DD</sub> = 3.0 V	-	60	90	mΩ	
		V <sub>DD</sub> = 3.6 V	-	57	82	mΩ	
R <sub>ON(GRD_flat)</sub>	GRD switch-on resistance	$I_{ICONx} = 10 \text{ mA}, V_{DD} = 1.8 \text{ V} \sim 3.6 \text{ V}$	-	-	50	mΩ	
OIN(GRD_IIAL)	flatness	$I_{ICONx} = 1 \text{ mA}, V_{DD} = 1.8 \text{ V} \sim 3.6 \text{ V}$	-	-	50	mΩ	
PSRR	power supply ripple rejection ratio of the conducting GRD switch	$V_S = 1 \text{ V, } R_S = 8 \Omega, \\ V_{DD} = 3.0 \text{ V, } V_{AC} = 0.3 \text{ V}_{PP}, \text{ f} = 217 \text{ Hz}; \\ \text{SEL} = \text{H or L}$	-	-60	-	dB	

# Audio jack configuration switch matrix

 Table 7.
 Static characteristics ...continued

At recommended operating conditions  $T_{amb} = -40 \, ^{\circ}\text{C}$  to +85  $^{\circ}\text{C}$  unless otherwise specified. Typical values are measured with  $V_{DD} = 3.0 \, \text{V}$  and  $T_{amb} = 25 \, ^{\circ}\text{C}$ . Voltages are referenced to GND (ground = 0 V). ...continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Sense switc	h SNS				,	
R <sub>ON(SNS)</sub>	SNS	I <sub>Isense</sub> = 30 mA, SNSx= 0 V				
	switch on resistance	V <sub>DD</sub> = 1.8 V	-	80	130	mΩ
		V <sub>DD</sub> = 3.0 V	-	60	90	mΩ
		V <sub>DD</sub> = 3.6 V	-	57	82	mΩ
R <sub>ON(SNS_flat)</sub>	SNS switch-on resistance flatness	$I_{Isense} = 10 \text{ mA}, \text{ SNSx} = 0 \text{ V},$ $V_{DD} = 1.8 \text{ V} \sim 3.6 \text{ V}$	-	-	50	mΩ
		$I_{Isense}$ = 1 mA, SNSx= 0 V, $V_{DD}$ = 1.8 V ~ 3.6 V	-	-	50	mΩ
I <sub>S(SNS_OFF)</sub> SNS switch leakage		Sense; V <sub>sense</sub> = 1 V				
	current	SEL = H; SNS1 =GND; SNS2 = OPEN	-	-	1	μΑ
		SEL = L; SNS1 = OPEN; SNS2 = GND	-	-	1	μΑ

# Audio jack configuration switch matrix

# 13.1 Test circuit and graphs

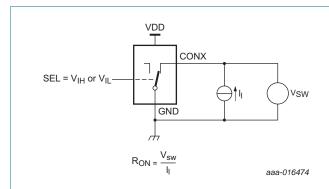


Fig 5. Test circuit for measuring ON resistance

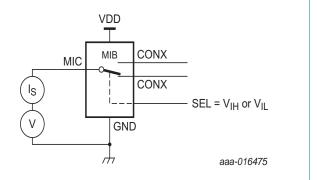
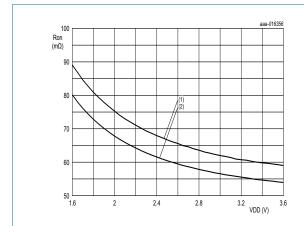
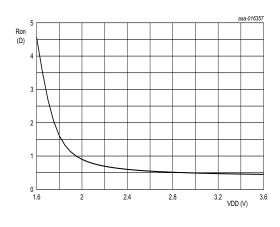


Fig 6. Test circuit for measuring leakage current



- (1) SNS RON
- (2) GRD RON

Fig 7. GRD and SNS channel ON resistance



MIB RON

Fig 8. MIB channel ON resistance

### Audio jack configuration switch matrix

# 14. Dynamic characteristics

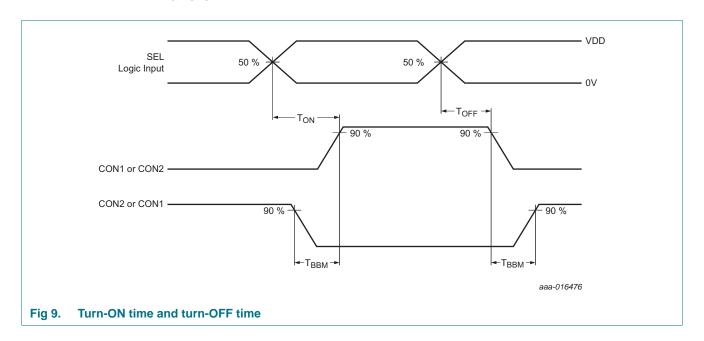
#### Table 8. Dynamic characteristics

At recommended operating conditions  $T_{amb} = -40$  °C to +85 °C unless otherwise specified. Typical values are measured with  $V_{DD} = 3.0$  V and  $T_{amb} = 25$  °C. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max [1]	Unit
t <sub>ON</sub>	Turn-ON Time	$\begin{aligned} &V_{\text{MIC}} = V_{\text{DD}}, \ V_{\text{sense}} = 0 \ V, \\ &R_{\text{L}} = 50 \ \Omega, \ C_{\text{L}} = 35 \ \text{pF} \end{aligned}$	-	215	400	ns
t <sub>OFF</sub>	Turn-OFF Time	$V_{MIC} = V_{DD}$ , $V_{sense} = 0$ V, $R_L = 50 \Omega$ , $C_L = 35 pF$	-	35	120	ns
t <sub>BBM</sub>	break-before-make time	$V_{MIC} = V_{DD}, V_{sense} = 0 V,$ $R_L = 50 \Omega, C_L = 35 pF$	70[1]	180	320	ns

#### [1] Guaranteed by design

#### 14.1 Waveform



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# 15. Package outline

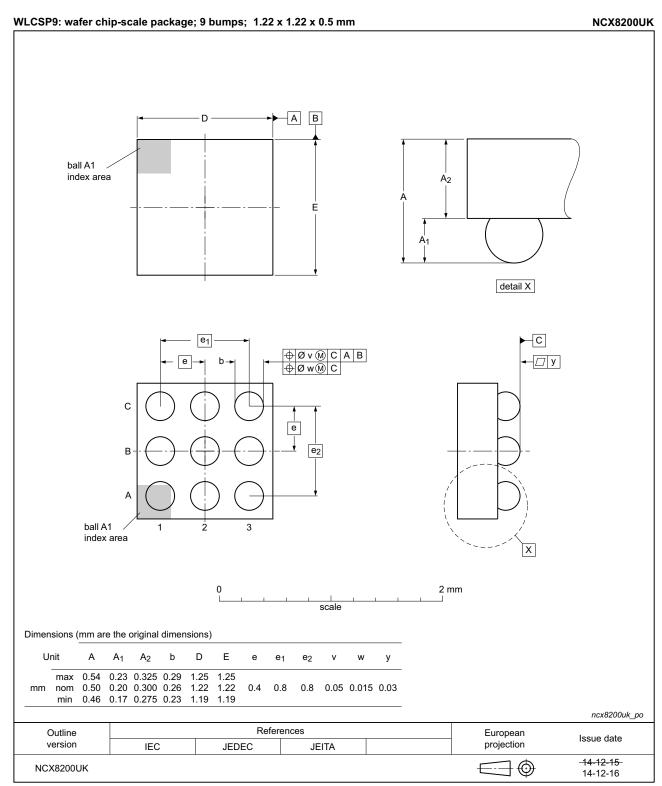


Fig 10. Package outline NCX8200 (WLCSP9)

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# 16. Abbreviations

Table 9. Abbreviations

Acronym	Description	
THD	Total Harmonic Distortion	
CDM	harged Device Model	
DUT	Device Under Test	
ESD	ElectroStatic Discharge	
НВМ	Human Body Model	
MOSFET	Metal-Oxide Semiconductor Field Effect Transistor	

# 17. Revision history

### Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
NCX8200 v.1	20150515	Product data sheet	-	-

#### Audio jack configuration switch matrix

# 18. Legal information

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Document status[1][2]	Product status[3] Definition	
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